

MXR3866**CASE 345-01, STYLE 1
SOT-89****RF TRANSISTOR**

NPN SILICON

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CEO}	30	V
Collector-Base Voltage	V_{CBO}	55	V
Emitter-Base Voltage	V_{EBO}	3.5	V
Collector Current — Continuous	I_C	0.4	A
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-55 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
*Total Device Dissipation, $T_A = 25^\circ\text{C}$ Derate above 25°C	P_D	1.0 8.0	Watt $\text{mW}/^\circ\text{C}$
Storage Temperature	T_{stg}	150	°C
*Thermal Resistance Junction to Ambient	$R_{\theta JA}$	125	°C/W

*Package mounted on 99.5% alumina 10 x 12 x 0.6 mm.

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Collector-Emitter Breakdown Voltage ($I_C = 5.0 \text{ mA}$, $R_{BE} = 10 \Omega$)	$V_{(BR)CER}$	55	—	V
Collector-Emitter Sustaining Voltage ($I_C = 5.0 \text{ mA}$)	$V_{CEO(\text{sus})}$	30	—	V
Collector-Base Breakdown Voltage ($I_C = 0.1 \text{ mA}$)	$V_{(BR)CBO}$	55	—	V
Emitter-Base Breakdown Voltage ($I_E = 0.1 \text{ mA}$)	$V_{(BR)EBO}$	3.5	—	V
Collector Cutoff Current ($V_{CE} = 28 \text{ V}$)	I_{CEO}	—	20	μA
Collector Cutoff Current ($V_{CE} = 55 \text{ V}$, $V_{BE} = 1.5 \text{ V}$)	I_{CEX}	—	100	μA
ON CHARACTERISTICS				
DC Current Gain ($I_C = 0.36 \text{ A}$, $V_{CE} = 5.0 \text{ V}$) ($I_C = 0.05 \text{ A}$, $V_{CE} = 5.0 \text{ V}$)	h_{FE}	5.0 10	— 200	—
Collector-Emitter Saturation Voltage ($I_C = 100 \text{ mA}$, $I_B = 20 \text{ mA}$)	$V_{CE(\text{sat})}$	—	1.0	V
SMALL-SIGNAL CHARACTERISTICS				
Current-Gain — Bandwidth Product ($I_C = 50 \text{ mA}$, $V_{CE} = 15 \text{ V}$, $f = 200 \text{ MHz}$)	f_T	500	—	MHz
Output Capacitance ($V_{CB} = 30 \text{ V}$, $f = 1.0 \text{ MHz}$)	C_{obo}	—	3.0	pF